

## **NanoCharacterization Lab**

## Equipment and Services Fees

NCL FEES			
Equipment	Manufacturer	Technique	Cost/hour
SEM-FEG FEI Inspect F	FEI	Scanning Electron Microscopy	65,00€
Ellipsometer SOPRA GES5-E	SOPRA	Spectroscopic Ellipsometry	29,40 €
AFM Veeco Dimension 3100	VEECO	Atomic Forces Microscopy	58,80 €
AFM Park NX10	PARK SYSTEMS	Atomic Forces Microscopy	42,30 €
KLA Tencor Alpha-Step Surface Profiler	KLA TENCOR	Profilometry	36,80 €
FIB Zeiss Auriga CrossBeam	Focused Ion Beam	ZEISS	113,80 €
FIB Zeiss Orion NanoFab	Focused Ion Beam	ZEISS	133,70 €

## Important notes:

- 1. The materials and accessories to use the System are not included.
- 2. The fees of the support technicians are the following:
  - a. Technician: 40€/hour
  - b. Supervisor: 60€/hour